## Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/769,155	Reexamination VEPREK ET AL.	
Examiner	Art Unit	
KALPANA BHARADWAJ	2129	Page 1 of 1

## U.S. PATENT DOCUMENTS

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0198946	12-2002	Wang et al.	709/206
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-		-	
	Н	US-			
	Т	US-			
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## FOREIGN PATENT DOCUMENTS

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## NON DATENT DOCUMENTS

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